

<b>Notice of References Cited</b>	Application/Control No. 10/656,727		Applicant(s)/Patent Under Reexamination HASEGAWA ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0046949 A1	03-2004	Ohgushi et al.	355/053
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	EP001396760A2	10-2004		Hasegawa et al	G03F 7/20
	O					
	P					
	Q					
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**NON-PATENT DOCUMENTS**

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